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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet 1 of 1				Complete If Known
				Application Number 10/828,508-Conf. #9644
				Filing Date April 20, 2004
				First Named Inventor Frank S. Bono
				Art Unit N/A
				Examiner Name Not Yet Assigned
				Attorney Docket Number 101896-0232

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
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		Country Code ⁴ -Number ⁵ -Kind Code ⁶ (if known)				
• JV	BA	DE 94 03 231	04-21-1994	Griebbach et al.		
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• JV	BC	WO 00/19923	04-12-2000	Yuan Hansen		

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NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ³

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